

1M x 64 144 PIN SODIMM

Features

- 144 Pin JEDEC Standard, 8 Byte Small Outline Dual In-line Memory Module with 8 Byte busses

- Performance:

		-60	-70
t_{RAC}	$\overline{RAS}$ Access Time	60ns	70ns
t_{CAC}	$\overline{CAS}$ Access Time	15ns	20ns
t_{AA}	Access Time From Address	30ns	35ns
t_{RC}	Cycle Time	110ns	130ns
t_{PC}	Page Mode Cycle Time	40ns	45ns

- All inputs and outputs are LVTTTL (3.3V) compatible
- Single 3.3V $\pm$ 0.3V Power Supply
- Au contacts
- Optimized for byte-write non-parity applications
- System Performance Benefits:

- Reduced noise (18 V_{SS} /18 V_{CC} pins)
- Byte write, byte read accesses
- Serial PDs

- Fast Page Mode, Read-Modify-Write Cycles
- Refresh Modes: $\overline{RAS}$ -Only, CBR Hidden Refresh, and Self Refresh
- 1024 refresh cycles distributed across 128ms
- 10/10 addressing (Row/Column)
- Card size: 2.66" x 1.0" x 0.149"
- DRAMS in TSOP Package

Description

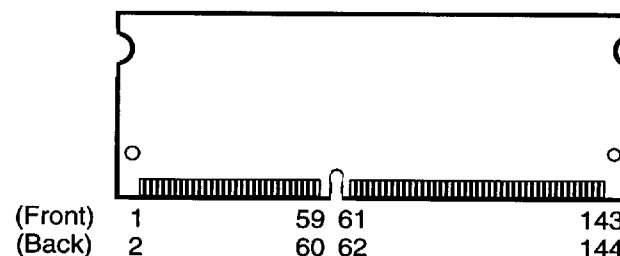
IBM11T1640L is an industry standard 144-pin 8-byte Small Outline Dual In-line Memory Module (SODIMM) which is organized as a 1Mx64 high speed memory array designed for use in non-parity applications. The DIMM uses 4 1Mx16 DRAMs in TSOP packages.

This card uses *serial presence detects* implemented via a serial EEPROM using the two pin I²C Protocol. This communication protocol uses CLOCK (SCL) and DATA I/O (SDA) lines to synchronously clock data between the master (ex: The System Micropro-

cessor) and the slave EEPROM device. The device address for the EEPROM is set to zero at the card. The first 128 bytes are utilized by the SODIMM manufacturer and the second 128 bytes are available to the end user.

All IBM 144-pin SODIMMs provide a high performance, flexible 8-byte interface in a 2.66" long space-saving footprint. Related products are the 2Mx64 Fast Page Mode and the 1Mx64, 2Mx64, 4Mx64 and the x72 (ECC) EDO SODIMMs.

Card Outline (3.3V)



Pin Description

RAS0	Row Address Strobe
CAS0 - CAS7	Column Address Strobe
WE	Read/write Input
OE	Output Enable
A0 - A9	Address Inputs
DQ0 - DQ63	Data Input/Output
V _{CC}	Power (3.3V)
V _{SS}	Ground
NC	No Connect
SCL	Serial Presence Detect Clock Input
SDA	Serial Presence Detect Data Input

Pinout

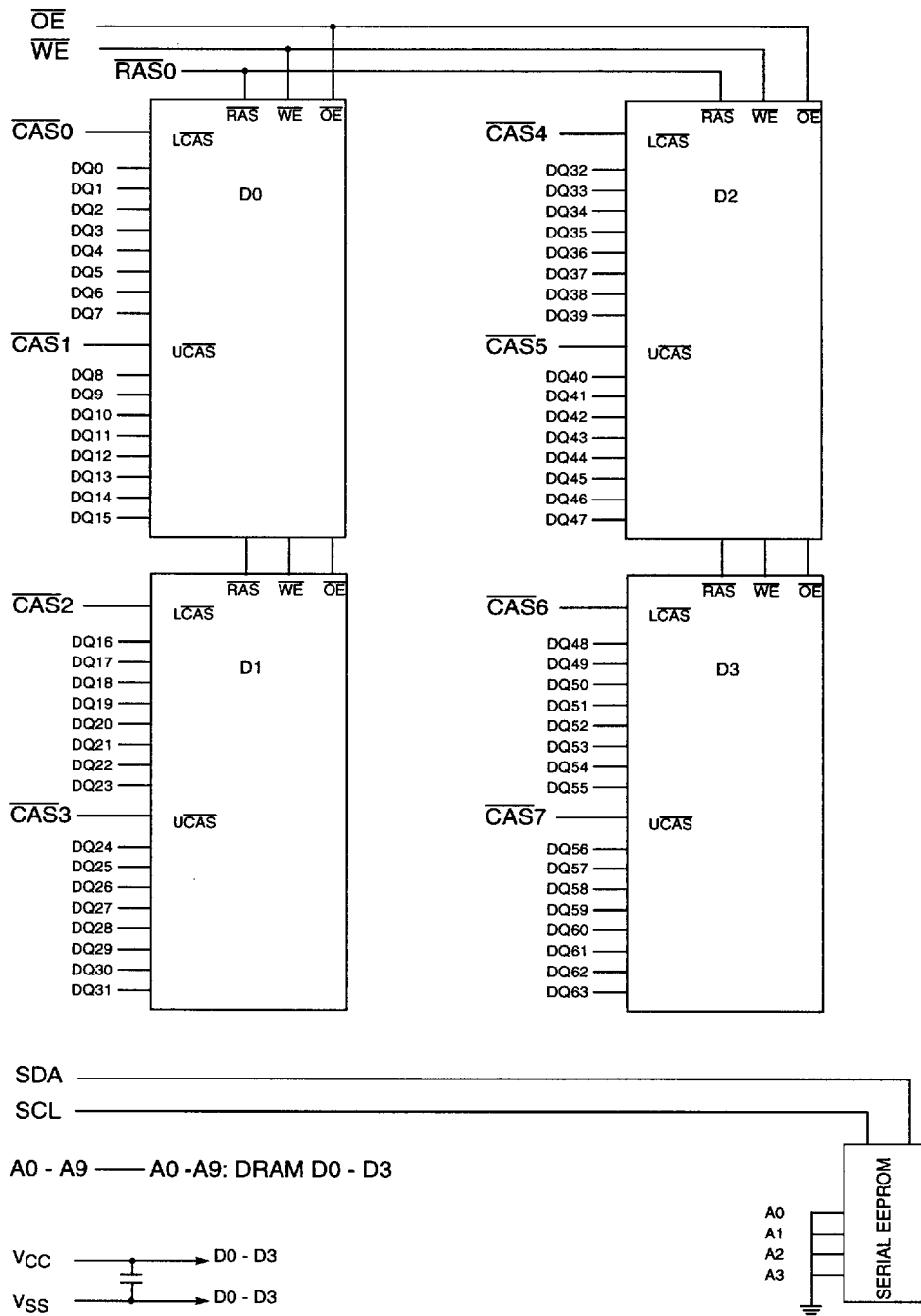
Pin#	Front Side	Pin#	Back Side	Pin#	Front Side	Pin#	Back Side
1	V _{SS}	2	V _{SS}	73	OE	74	NC
3	DQ0	4	DQ32	75	V _{SS}	76	V _{SS}
5	DQ1	6	DQ33	77	NC	78	NC
7	DQ2	8	DQ34	79	NC	80	NC
9	DQ3	10	DQ35	81	V _{CC}	82	V _{CC}
11	V _{CC}	12	V _{CC}	83	DQ16	84	DQ48
13	DQ4	14	DQ36	85	DQ17	86	DQ49
15	DQ5	16	DQ37	87	DQ18	88	DQ50
17	DQ6	18	DQ38	89	DQ19	90	DQ51
19	DQ7	20	DQ39	91	V _{SS}	92	V _{SS}
21	V _{SS}	22	V _{SS}	93	DQ20	94	DQ52
23	CAS0	24	CAS4	95	DQ21	96	DQ53
25	CAS1	26	CAS5	97	DQ22	98	DQ54
27	V _{CC}	28	V _{CC}	99	DQ23	100	DQ55
29	A0	30	A3	101	V _{CC}	102	V _{CC}
31	A1	32	A4	103	A6	104	A7
33	A2	34	A5	105	A8	106	A11
35	V _{SS}	36	V _{SS}	107	V _{SS}	108	V _{SS}
37	DQ8	38	DQ40	109	A9	110	A12
39	DQ9	40	DQ41	111	A10	112	A13
41	DQ10	42	DQ42	113	V _{CC}	114	V _{CC}
43	DQ11	44	DQ43	115	CAS2	116	CAS6
45	V _{CC}	46	V _{CC}	117	CAS3	118	CAS7
47	DQ12	48	DQ44	119	V _{SS}	120	V _{SS}
49	DQ13	50	DQ45	121	DQ24	122	DQ56
51	DQ14	52	DQ46	123	DQ25	124	DQ57
53	DQ15	54	DQ47	125	DQ26	126	DQ58
55	V _{SS}	56	V _{SS}	127	DQ27	128	DQ59
57	NC	58	NC	129	V _{CC}	130	V _{CC}
59	NC	60	NC	131	DQ28	132	DQ60
VOLTAGE KEY				133	DQ29	134	DQ61
61	DU	62	DU	135	DQ30	136	DQ62
63	V _{CC}	64	V _{CC}	137	DQ31	138	DQ63
65	DU	66	DU	139	V _{SS}	140	V _{SS}
67	WE	68	NC	141	SDA	142	SCL
69	RAS0	70	NC	143	V _{CC}	144	V _{CC}
71	NC	72	NC				

Note: All pin assignments are consistent for all 8 Byte versions.

Ordering Information

Part Number	Organization	Speed	Leads	Dimension	Power	Notes
IBM11T1640LP-60	1Mx64	60ns	Au	2.66"x1.0"x 0.149"	3.3V	
IBM11T1640LP-70	1Mx64	70ns	Au	2.66"x1.0"x 0.149"	3.3V	

Block Diagram



Truth Table

Function	RAS	CAS	WE	Row Address	Column Address	All DQ bits
Standby	H	X	X	X	X	High Impedance
Read	L	L	H	Row	Col	Valid Data Out
Early-Write	L	L	L	Row	Col	Valid Data In
Fast Page Mode - Read: 1st Cycle	L	H→L	H	Row	Col	Valid Data Out
Subsequent Cycles	L	H→L	H	N/A	Col	Valid Data Out
Fast Page Mode - Write: 1st Cycle	L	H→L	L	Row	Col	Valid Data In
Subsequent Cycles	L	H→L	L	N/A	Col	Valid Data In
RAS-Only Refresh	L	H	X	Row	N/A	High Impedance
CAS-Before-RAS Refresh	H→L	L	H	X	X	High Impedance

Serial Presence Detect

Byte #		Description	SPD Entry Value	SPD Entry								Hex
				Binary								
				Bit 7	Bit 6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	
0	Number of SPD Bytes		128	1	0	0	0	0	0	0	0	80
1	Total # Bytes in Serial PD		256	0	0	0	0	1	0	0	0	08
2	Memory Type		Fast Page	0	0	0	0	0	0	0	1	01
3	# of Row Addresses		10	0	0	0	0	1	0	1	0	0A
4	# of Column Addresses		10	0	0	0	0	1	0	1	0	0A
5	# of Sodimm Banks		1	0	0	0	0	0	0	0	1	01
6	Module Data Width		64	0	1	0	0	0	0	0	0	40
7	Module Data Width (Cont.)		0	0	0	0	0	0	0	0	0	00
8	Module Interface Levels		LVTTTL	0	0	0	0	0	0	0	1	01
9	Ras Access	60ns	60	0	0	1	1	1	1	0	0	3C
		70ns	70	0	1	0	0	0	1	1	0	46
10	Cas Access	15ns	15	0	0	0	0	1	1	1	1	0F
		20ns	20	0	0	0	1	0	1	0	0	14
11	Dimm Config(Error Det/Corr.)		None	0	0	0	0	0	0	0	0	00
12	Refresh Rate/Type		SR/8x(125us)	1	0	0	0	0	1	0	1	85
1.												

Absolute Maximum Ratings

Symbol	Parameter	Rating (3.3V)	Units	Notes
V _{CC}	Power Supply Voltage	-0.5 to +4.6	V	1
V _{IN}	Input Voltage	-0.5 to min (V _{CC} + 0.5, 4.6)	V	1
V _{IN/OUT} (SPD)	Input Voltage(Serial PD Device)	-0.3 to 6.5	V	1
V _{OUT}	Output Voltage	-0.5 to min (V _{CC} + 0.5, 4.6)	V	1
T _{OPR}	Operating Temperature	0 to +70	°C	1
T _{STG}	Storage Temperature	-55 to +150	°C	1
P _D	Power Dissipation	3.0	W	1
I _{OUT}	Short Circuit Output Current	50	mA	1

1. Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated is not implied. Exposure to absolute maximum rating condition for extended periods may affect reliability.

Recommended DC Operating Conditions (T_A = 0 to 70°C)

Symbol	Parameter	3.3V			Units	Notes
		Min	Typ	Max		
V _{CC}	Supply Voltage	3.0	3.3	3.6	V	1
V _{IH}	Input High Voltage	2.0	—	V _{CC} + 0.5	V	1, 2
V _{IH} (SPD)	Input High Voltage(Serial PD Device)	V _{CC} × 0.7	—	V _{CC} + 0.5	V	1, 2
V _{IL}	Input Low Voltage	-0.5	—	0.8	V	1, 2
V _{IL} (SPD)	Input Low Voltage(Serial PD Device)	-0.3	—	V _{CC} × 0.3	V	1, 2
V _{OL} (SPD)	Output Low Voltage(Serial PD Device) I _{OL} = 3ma	—	—	0.4	V	

1. All voltages referenced to V_{SS}.
2. V_{IH} may overshoot to V_{CC} + 1.2V for pulse widths of ≤ 4.0ns . Additionally, V_{IL} may undershoot to -1.2V for pulse widths ≤ 4.0ns. Pulse widths measured at 50% points with amplitude measured peak to DC reference.

Capacitance (T_A = 0 to +70°C, V_{CC} = 3.3V ± 0.3V)

Symbol	Parameter	Max	Units	Notes
C _{I1}	Input Capacitance (A0-A9)	36	pF	
C _{I2}	Input Capacitance (RAS, WE, OE)	42	pF	
C _{I3}	Input Capacitance (CAS)	16	pF	
C _{I4}	Input Capacitance (SCL)	8	pF	
C _{IO1}	Input/Output Capacitance (DQ0-63)	11	pF	
C _{IO2}	Input/Output Capacitance (SDA)	10	pF	

DC Electrical Characteristics ($T_A = 0$ to $+70^\circ\text{C}$, $V_{CC} = 3.3\text{V} \pm 0.3\text{V}$)

Symbol	Parameter	3.3 Volt		Units	Notes
		Min.	Max.		
I_{CC1}	Operating Current Average Power Supply Operating Current ($\overline{\text{RAS}}$, $\overline{\text{CAS}}$, Address Cycling: $t_{RC} = t_{RC \text{ min.}}$)	-60	820	mA	1, 2, 3
		-70	720		
I_{CC2}	Standby Current (TTL) Power Supply Standby Current ($\overline{\text{RAS}} = \overline{\text{CAS}} = V_{IH}$)	—	8.1	mA	
I_{CC3}	$\overline{\text{RAS}}$ Only Refresh Current Average Power Supply Current, $\overline{\text{RAS}}$ Only Mode ($\overline{\text{RAS}}$ Cycling, $\overline{\text{CAS}} = V_{IH}$; $t_{RC} = t_{RC \text{ min.}}$)	-60	820	mA	1, 3
		-70	720		
I_{CC4}	Fast Page Mode Current Average Power Supply Current, Fast Page Mode ($\overline{\text{RAS}} = V_{IL}$, $\overline{\text{CAS}}$, Address Cycling: $t_{PC} = t_{PC \text{ min.}}$)	-60	360	mA	1, 2, 3
		-70	320		
I_{CC5}	Standby Current (CMOS) Power Supply Standby Current ($\overline{\text{RAS}} = \overline{\text{CAS}} = V_{CC} - 0.2\text{V}$)	—	900	μA	
I_{CC6}	$\overline{\text{CAS}}$ Before $\overline{\text{RAS}}$ Refresh Current Average Power Supply Current during Self Refresh CBR cycle with $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, Cycling: $t_{RC} = t_{RC \text{ min.}}$)	-60	820	mA	1, 3
		-70	720		
I_{CC7}	Self Refresh Current Average Power Supply Current during Self Refresh CBR cycle with $\overline{\text{RAS}} \geq t_{RASS} \text{ (min.)}$; $\overline{\text{CAS}}$ held low; $\overline{\text{WE}} = V_{CC} - 0.2\text{V}$; Addresses and $D_{IN} = V_{CC} - 0.2\text{V}$ OR 0.2.	—	900	μA	
$I_{IL(L)}$	Input Leakage Current Input Leakage Current, any input ($0.0 \leq V_{IN} \leq (V_{CC} + 0.3\text{V})$), All Other Pins Not Under Test = 0V x=y	$\overline{\text{RAS}}, \overline{\text{WE}}, \overline{\text{OE}}, \text{ADD}$	-40	+40	μA
		$\overline{\text{CAS}}$	-10	+10	
$I_{OL(L)}$	Output Leakage Current (D_{OUT} is disabled, $0.0 \leq V_{OUT} \leq V_{CC}$)	-10	+10	μA	
V_{OH}	Output Level (TTL) Output "H" Level Voltage ($I_{OUT} = -5\text{mA}$)	2.4	V_{CC}	V	
V_{OL}	Output Level (TTL) Output "L" Level Voltage ($I_{OUT} = +4.2\text{mA}$)	0.0	0.4	V	

1. I_{CC1} , I_{CC3} , I_{CC4} and I_{CC6} depend on cycle rate.
 2. I_{CC1} and I_{CC4} depend on output loading. Specified values are obtained with the output open.
 3. Address can be changed once or less while $\overline{\text{RAS}} = V_{IL}$. In the case of I_{CC4} , it can be changed once or less when $\overline{\text{CAS}} = V_{IH}$.

AC Characteristics (T_A = 0 to +70C, V_{CC} = 3.3 0.3V)

1. An initial pause of 200μs is required after power-up followed by 8 $\overline{\text{RAS}}$ only refresh cycles before proper device operation is achieved. In case of using the internal refresh counter, a minimum of 8 $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh cycles instead of 8 $\overline{\text{RAS}}$ only refresh cycles is required.
2. AC measurements assume t_f=5ns.
3. V_{IH}(min.) and V_{IL}(max.) are reference levels for measuring timing of input signals. Also, transition times are measured between V_{IH} and V_{IL}.
4. When both $\overline{\text{LCAS}}$ and $\overline{\text{UCAS}}$ (REFERENCE BLOCK DIAGRAM, PAGE 5) go low at the same time, all 16 bits of data are read/written into the device. $\overline{\text{LCAS}}$ and $\overline{\text{UCAS}}$ cannot be staggered within the same read/write cycle.

Read, Write, and Refresh Cycles (Common Parameters)

Symbol	Parameter	-60		-70		Units	Notes
		Min.	Max.	Min.	Max.		
t _{RC}	Random Read or Write Cycle Time	110	—	130	—	ns	
t _{RP}	$\overline{\text{RAS}}$ Precharge Time	40	—	50	—	ns	
t _{CP}	$\overline{\text{CAS}}$ Precharge Time	10	—	10	—	ns	
t _{RAS}	$\overline{\text{RAS}}$ Pulse Width	60	10K	70	10K	ns	
t _{CAS}	$\overline{\text{CAS}}$ Pulse Width	15	10K	20	10K	ns	
t _{ASR}	Row Address Setup Time	0	—	0	—	ns	
t _{RAH}	Row Address Hold Time	10	—	10	—	ns	
t _{ASC}	Column Address Setup Time	0	—	0	—	ns	
t _{CAH}	Column Address Hold Time	15	—	15	—	ns	
t _{RCD}	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay Time	20	45	20	50	ns	1
t _{RAD}	$\overline{\text{RAS}}$ to Column Address Delay Time	15	30	15	35	ns	2
t _{RSH}	$\overline{\text{RAS}}$ Hold Time	15	—	20	—	ns	
t _{CSH}	$\overline{\text{CAS}}$ Hold Time	60	—	70	—	ns	
t _{CRP}	$\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ Precharge Time	5	—	5	—	ns	
t _{ODD}	$\overline{\text{OE}}$ to D _{IN} Precharge Time	15	—	20	—	ns	3
t _{DZO}	$\overline{\text{OE}}$ Delay Time from D _{IN}	0	—	0	—	ns	4
t _{DZC}	$\overline{\text{CAS}}$ Delay Time from D _{IN}	0	—	0	—	ns	4
t _T	Transition Time (Rise and Fall)	3	30	3	30	ns	

1. Operation within the t_{RCD}(max) limit ensures that t_{RAC}(max) can be met. The t_{RCD}(max) is specified as a reference point only: If t_{RCD} is greater than the specified t_{RCD}(max) limit, then access time is controlled by t_{CAC}.
2. Operation within the t_{RAD}(max) limit ensures that t_{RAC}(max) can be met. The t_{RAD}(max) is specified as a reference point only: If t_{RAD} is greater than the specified t_{RAD}(max) limit, then access time is controlled by t_{AA}.
3. Either t_{CDD} or t_{ODD} must be satisfied.
1. Either t_{DZC} or t_{DZO} must be satisfied.

Write Cycle

Symbol	Parameter	-60		-70		Unit	Notes
		Min	Max	Min	Max		
t_{WCS}	Write Command Set Up Time	0	—	0	—	ns	1
t_{WCH}	Write Command Hold Time	15	—	15	—	ns	
t_{WP}	Write Command Pulse Width	15	—	15	—	ns	
t_{RWL}	Write Command to $\overline{RAS}$ Lead Time	15	—	20	—	ns	
t_{CWL}	Write Command to $\overline{CAS}$ Lead Time	15	—	20	—	ns	
t_{DS}	D_{IN} Setup Time	0	—	0	—	ns	2
t_{DH}	D_{IN} Hold Time	15	—	15	—	ns	2

1. t_{WCS} , t_{RPD} , t_{CWD} , t_{AWD} , and t_{CPW} are not restrictive parameters. They are included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}(\text{min.})$, the entire cycle is an early write cycle and the data pin will remain open circuit (high impedance) through the entire cycle; If $t_{RPD} \geq t_{RPD}(\text{min.})$, $t_{CWD} \geq t_{CWD}(\text{min.})$, $t_{AWD} \geq t_{AWD}(\text{min.})$ and $t_{CPW} \geq t_{CPW}(\text{min.})$ (Fast Page Mode), the cycle is a Read-Modify-Write cycle and the data will contain read from the selected cell; If neither of the above sets of conditions are met, the condition of the data (at access time) is indeterminate.
2. These parameters are referenced to $\overline{LCAS}$ or $\overline{UCAS}$ leading edge in early write cycles and to $\overline{WE}$ leading edge in Read-Modify-Write cycles.

Read Cycle

Symbol	Parameter	-60		-70		Unit	Notes
		Min	Max	Min	Max		
t_{RAC}	Access Time from $\overline{RAS}$	—	60	—	70	ns	1, 2, 3
t_{CAC}	Access Time from $\overline{CAS}$	—	15	—	20	ns	1, 3
t_{AA}	Access Time from Address	—	30	—	35	ns	2, 3
t_{OEA}	Access Time from $\overline{OE}$	—	15	—	20	ns	3
t_{RCS}	Read Command Setup Time	0	—	0	—	ns	
t_{RCH}	Read Command Hold Time to $\overline{CAS}$	0	—	0	—	ns	4
t_{RRH}	Read Command Hold Time to $\overline{RAS}$	5	—	5	—	ns	4
t_{RAL}	Column Address to $\overline{RAS}$ Lead Time	30	—	35	—	ns	
t_{CAL}	Column Address to $\overline{RAS}$ Lead Time	30	—	35	—	ns	
t_{CLZ}	$\overline{CAS}$ to Output in Low-Z	0	—	0	—	ns	3
t_{CH}	OUTPUT DATA HOLD TIME	3	—	3	—	ns	
t_{OHO}	Output Data Hold from $\overline{OE}$	3	—	3	—	ns	
t_{OFF}	Output Buffer Turn-off Delay	—	15	—	20	ns	5
t_{OEZ}	Output Buffer Turn-off Delay from $\overline{OE}$	—	15	—	20	ns	5
t_{CDD}	$\overline{CAS}$ to D_{IN} Delay Time	15	—	20	—	ns	6

1. Operation within the $t_{RCD}(\text{max.})$ limit ensures that $t_{RAC}(\text{max.})$ can be met. $t_{RCD}(\text{max.})$ is specified as a reference point only. If t_{RCD} is greater than the specified $t_{RCD}(\text{max.})$ limit, then access time is controlled by t_{CAC} .
 2. Operation within the $t_{RAD}(\text{max.})$ limit ensures that $t_{RAC}(\text{max.})$ can be met. $t_{RAD}(\text{max.})$ is specified as a reference point only. If t_{RAD} is greater than the specified $t_{RAD}(\text{max.})$ limit, then access time is controlled by t_{AA} .
 3. Measured with the specified current load and 100pF at $V_{OL} = 0.8V$ and $V_{OH} = 2.0V$.
 4. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
 5. $t_{OFF}(\text{max})$ and $t_{OEZ}(\text{max})$ define the time at which the output achieves the open circuit condition and are not referenced to output voltage levels.
1. Either t_{CDD} or t_{ODD} must be satisfied.

Read-Modify-Write Cycle

Symbol	Parameter	-60		-70		Unit	Notes
		Min	Max	Min	Max		
t_{RWC}	Read-Modify-Write Cycle Time	150	—	180	—	ns	
t_{RWD}	RAS to $\overline{WE}$ Delay Time	80	—	95	—	ns	1
t_{CWD}	CAS to $\overline{WE}$ Delay Time	35	—	45	—	ns	1
t_{AWD}	Column Address to $\overline{WE}$ Delay Time	50	—	60	—	ns	1
t_{OEH}	$\overline{OE}$ Command Hold Time	15	—	20	—	ns	

1. t_{WCS} , t_{RWD} , t_{CWD} , t_{AWD} , and t_{CPW} are not restrictive parameters. They are included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}(\text{min.})$, the entire cycle is an early write cycle and the data pin will remain open circuit (high impedance) through the entire cycle; If $t_{RWD} \geq t_{RWD}(\text{min.})$, $t_{CWD} \geq t_{CWD}(\text{min.})$, $t_{AWD} \geq t_{AWD}(\text{min.})$ and $t_{CPW} \geq t_{CPW}(\text{min.})$ (Fast Page Mode), the cycle is a Read-Modify-Write cycle and the data will contain read from the selected cell; If neither of the above sets of conditions are met, the condition of the data (at access time) is indeterminate.

Fast Page Mode Cycle

Symbol	Parameter	-60		-70		Units	Notes
		Min.	Max.	Min.	Max.		
t_{PC}	Fast Page Mode Cycle Time	40	—	45	—	ns	
t_{RASP}	Fast Page Mode $\overline{RAS}$ Pulse Width	60	100K	70	100K	ns	
t_{CPA}	Access Time from $\overline{CAS}$ Precharge	—	35	—	40	ns	1
t_{CPRH}	$\overline{RAS}$ Hold Time from $\overline{CAS}$ Precharge	35	—	40	—	ns	

1. Measured with the specified current load and 100pF.

Fast Page Mode Read-Modify-Write Cycle

Symbol	Parameter	-60		-70		Units	Notes
		Min.	Max.	Min.	Max.		
t_{PRWC}	Fast Page Mode Read-Modify-Write Cycle Time	80	—	95	—	ns	
t_{CPW}	$\overline{WE}$ Delay Time from $\overline{CAS}$ Precharge	55	—	65	—	ns	1

1. t_{WCS} , t_{RWD} , t_{CWD} , t_{AWD} and t_{CPW} are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}(\text{min.})$, the cycle is an early write cycle and the data pin will remain open circuit (high impedance) through the entire cycle. If $t_{RWD} \geq t_{RWD}(\text{min.})$, $t_{CWD} \geq t_{CWD}(\text{min.})$, $t_{AWD} \geq t_{AWD}(\text{min.})$, and $t_{CPW} \geq t_{CPW}(\text{min.})$ (Fast Page Mode), the cycle is a Read-Modify-Write cycle and the data out will contain data read from the selected cell. If neither of the above sets of conditions are satisfied, the condition of the data out (at access time) is indeterminate.

Refresh Cycle

Symbol	Parameter	-60		-70		Unit	Notes
		Min	Max	Min	Max		
t_{CSR}	CAS Setup Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh Cycle)	10	—	10	—	ns	
t_{CHR}	CAS Hold Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh Cycle)	20	—	20	—	ns	
t_{WRP}	$\overline{WE}$ Setup Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh Cycle)	10	—	10	—	ns	
t_{WRH}	$\overline{WE}$ Hold Time ($\overline{CAS}$ before $\overline{RAS}$ Refresh Cycle)	10	—	10	—	ns	
t_{RPC}	$\overline{RAS}$ Precharge to $\overline{CAS}$ Hold Time	5	—	5	—	ns	
t_{REF}	Refresh Period	—	128	—	128	ms	1
1. 1024 refreshes are required every 128ms.							

Self Refresh Cycle

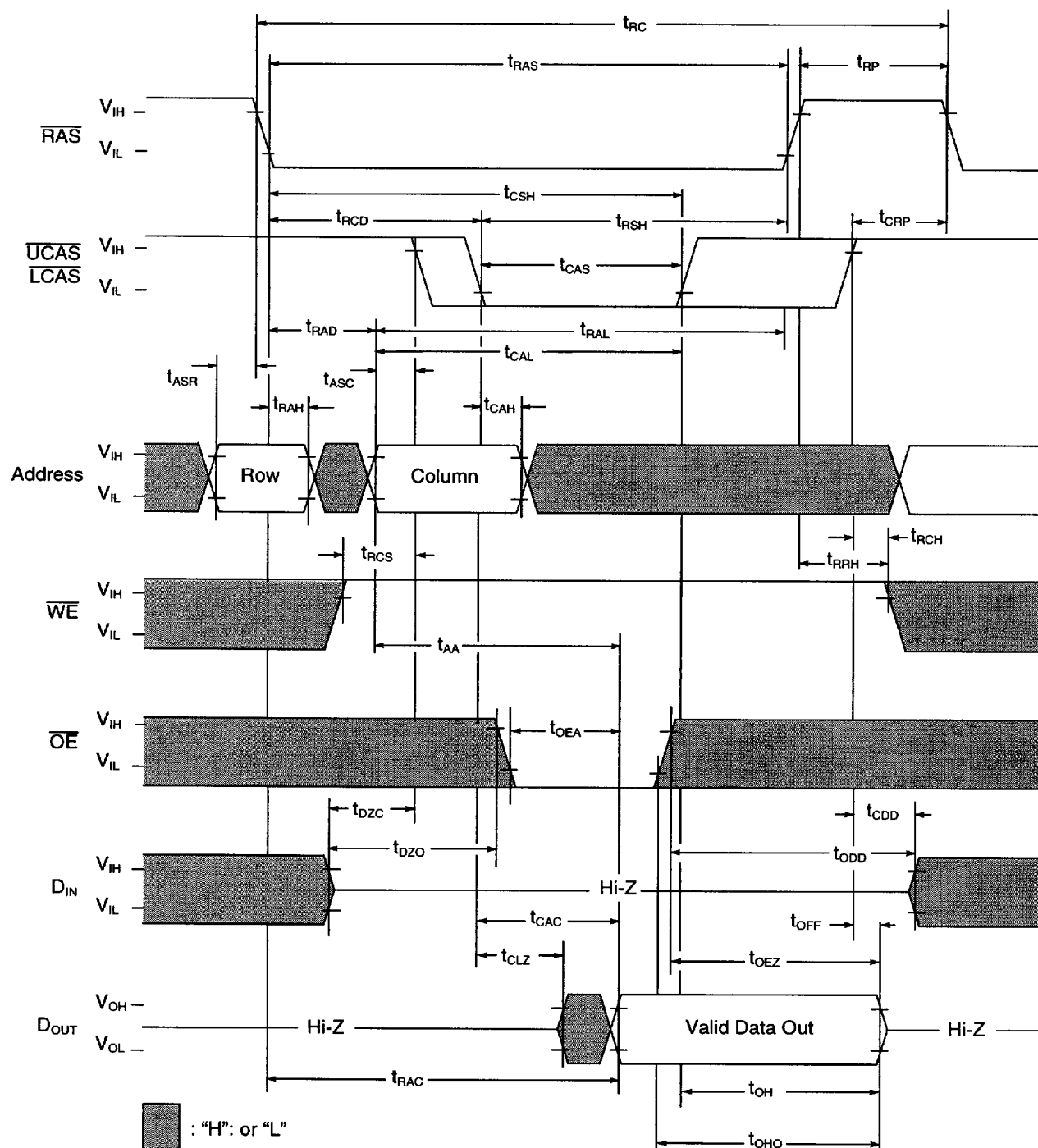
Symbol	Parameter	-60		-70		Unit	Notes
		Min	Max	Min	Max		
t_{RASS}	RAS Pulse Width During Self Refresh Cycle	100	—	100	—	ns	1
t_{RPS}	RAS Precharge Time During Self Refresh Cycle)	110	—	130	—	ns	1
t_{CHS}	CAS Hold Time During Self Refresh Cycle)	50	—	50	—	ns	1
1. When using Self Refresh mode, the following refresh operations must be performed to ensure proper DRAM operation: If row addresses are being refreshed in an EVENLY DISTRIBUTED manner over the refresh interval using CBR refresh cycles, then only one CBR cycle must be performed immediately after exit from Self Refresh. If row addresses are being refreshed in any other manner (ROR - Distributed/Burst; or CBR-Burst) over the refresh interval, then a full set of row refreshes must be performed immediately before entry to and immediately after exit from Self Refresh.							

Presence Detect Read and Write Cycle

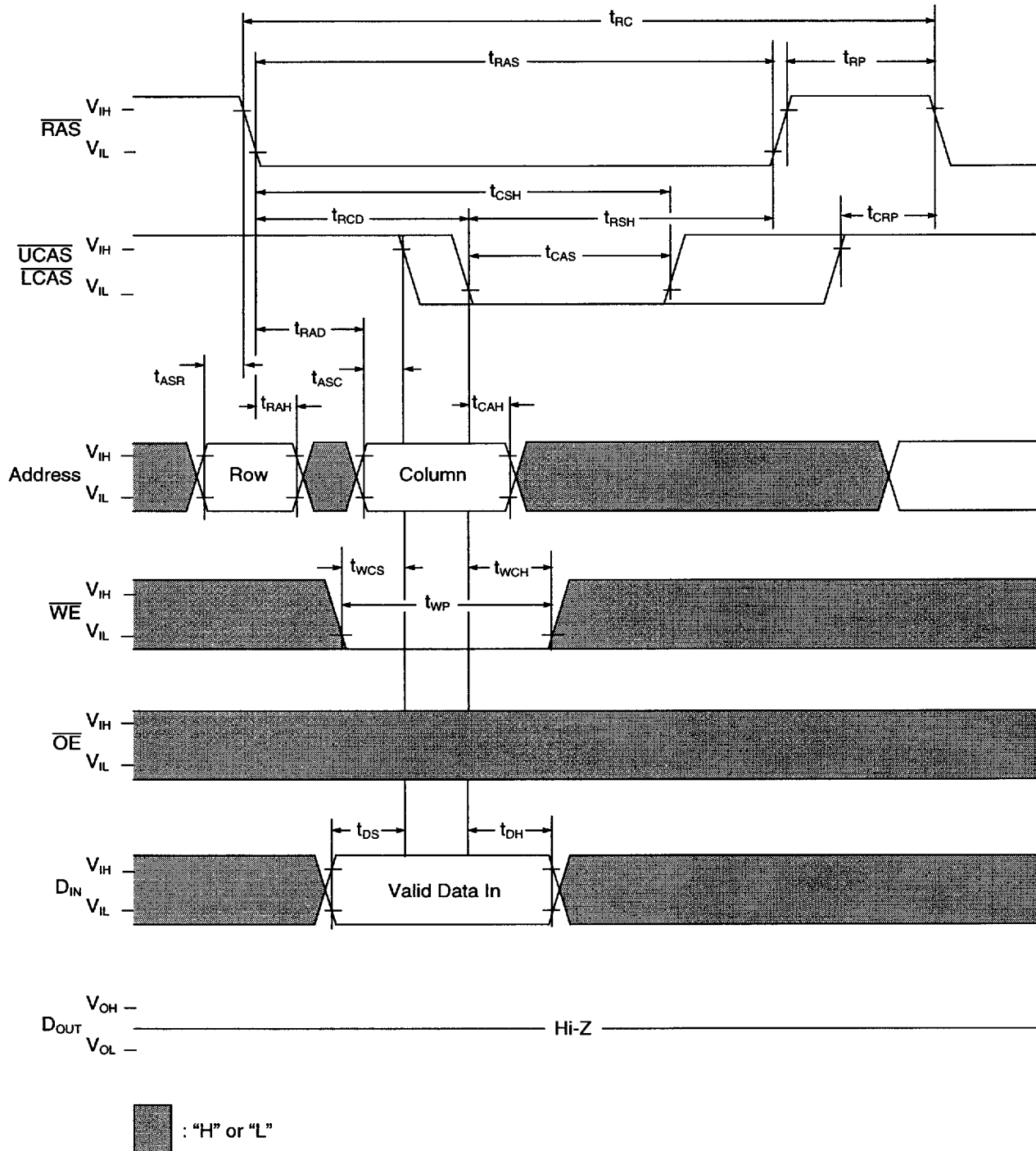
Symbol	Parameter	-70		Unit	Notes
		Min	Max		
f_{SCL}	SCL Clock Frequency		100	KHz	
T_I	Noise Suppression Time Constant at SCL, SDA Inputs		100	ns	
t_{AA}	SCL Low to SDA Data Out Valid	0.3	3.5	μ s	
t_{BUF}	Time the Bus Must Be Free before a New Transmission Can Start	4.7		μ s	
$t_{HD:STA}$	Start Condition Hold Time	4.0		μ s	
t_{LOW}	Clock Low Period	4.7		μ s	
t_{HIGH}	Clock High Period	4.0		μ s	
$t_{SU:STA}$	Start Condition Setup Time(for a Repeated Start Condition)	4.7		μ s	
$t_{HD:DAT}$	Data in Hold Time	0		μ s	
$t_{SU:DAT}$	Data in Setup Time	250		ns	
t_r	SDA and SCL Rise Time		1	μ s	
t_f	SDA and SCL Fall Time		300	ns	
$t_{SU:STO}$	Stop Condition Setup Time	4.7		μ s	
t_{DH}	Data Out Hold Time	300		ns	
$t_{WR}(\text{Note 3})$	Write Cycle Time		10	ms	

1. The write cycle time(t_{WR}) is the time from a valid stop condition of a write sequence to the end of the internal erase/program cycle. During the write cycle, the bus interface circuits are disabled, SDA is allowed to remain high per the bus-level pull-up resistor, and the device does not respond to its slave address.

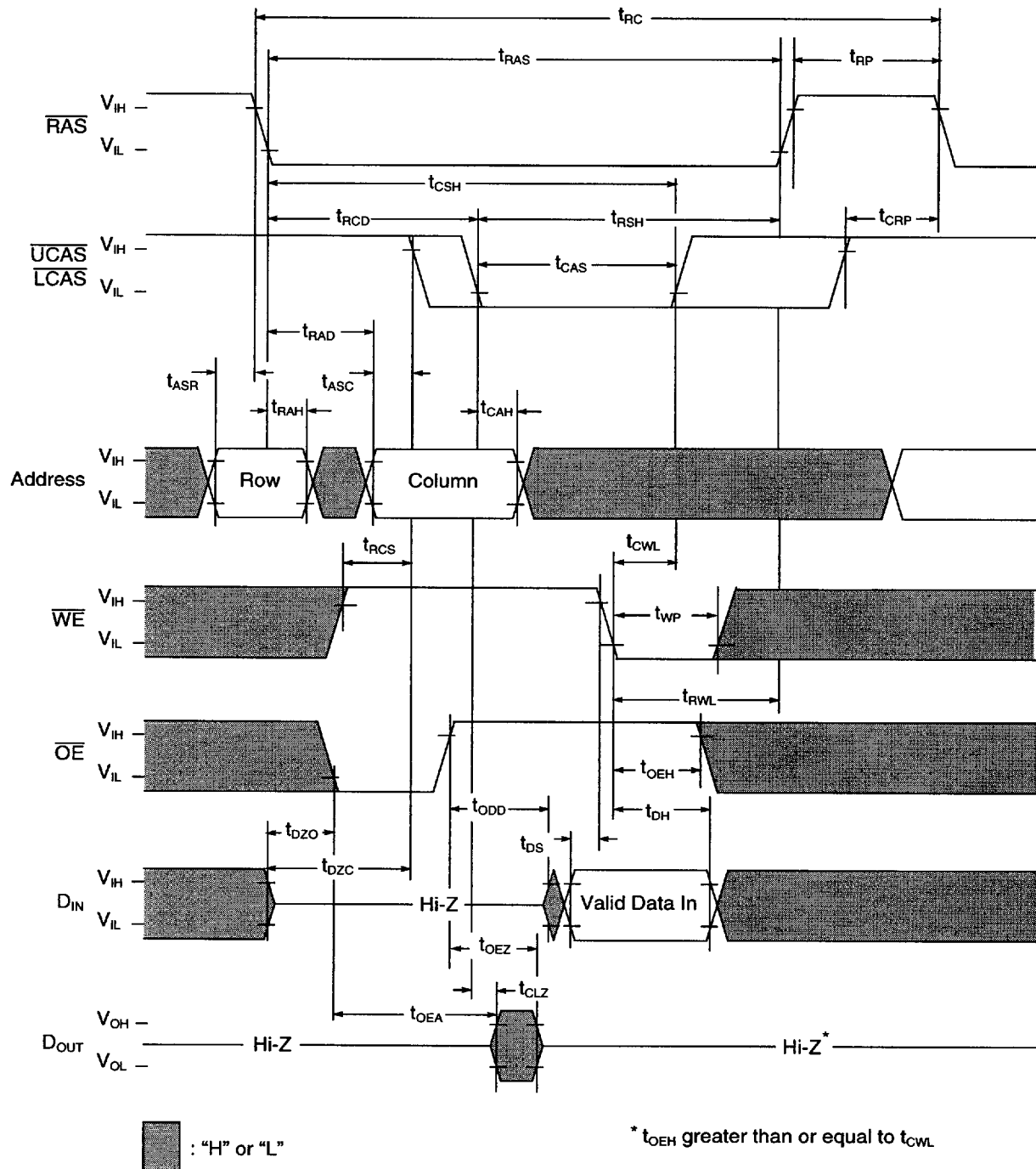
Read Cycle

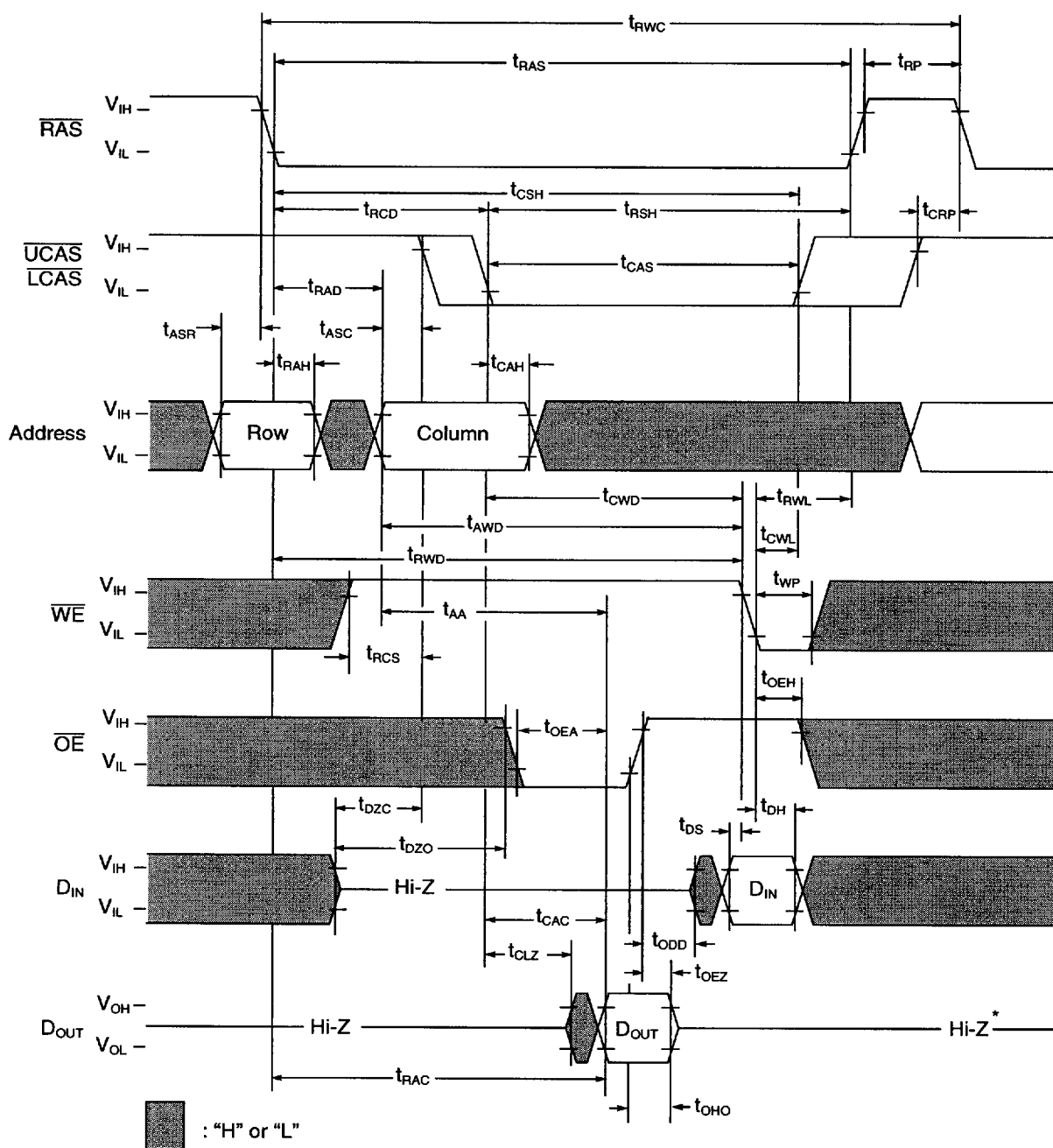


Write Cycle (Early Write)



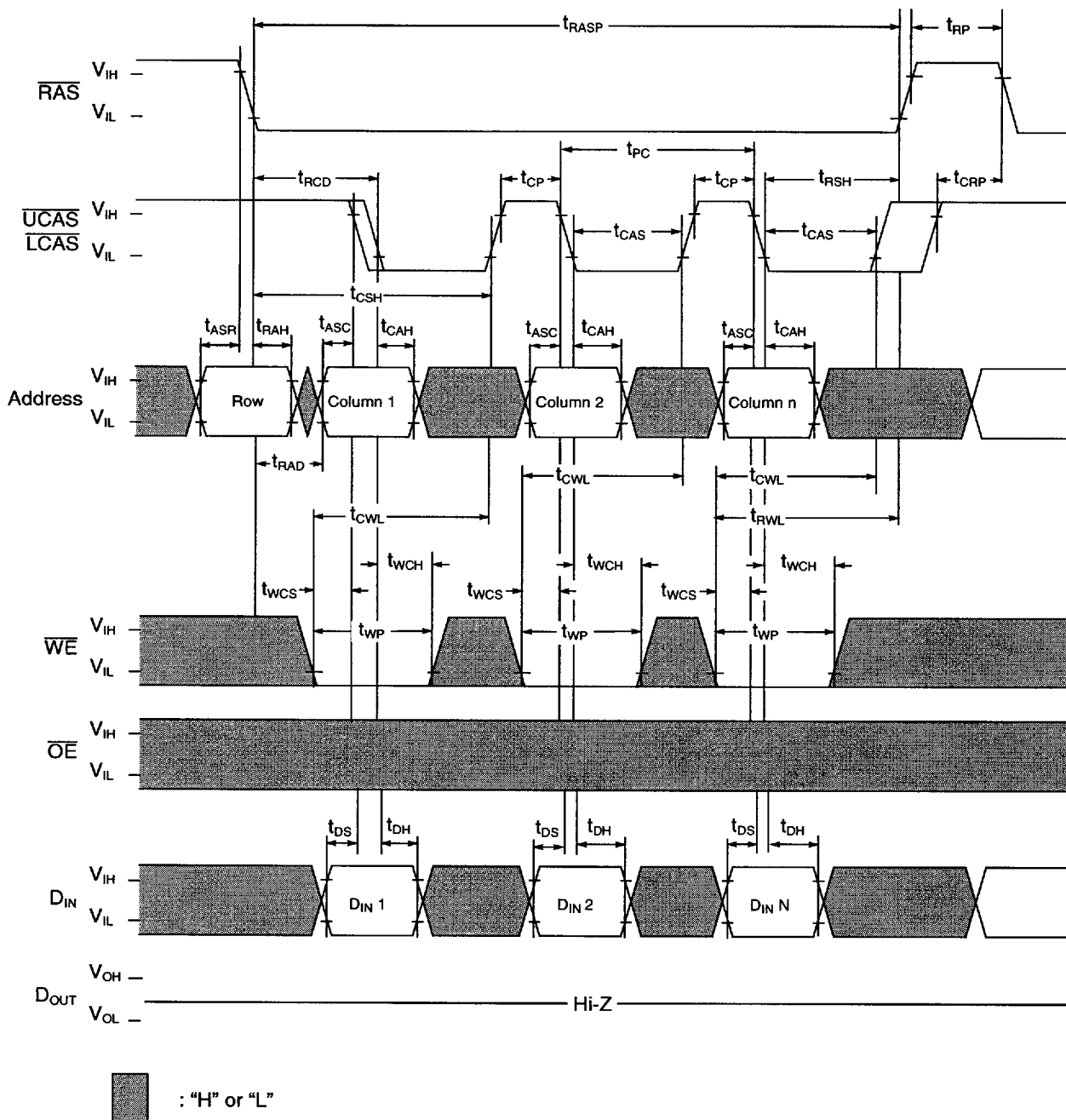
Write Cycle (Delayed Write)



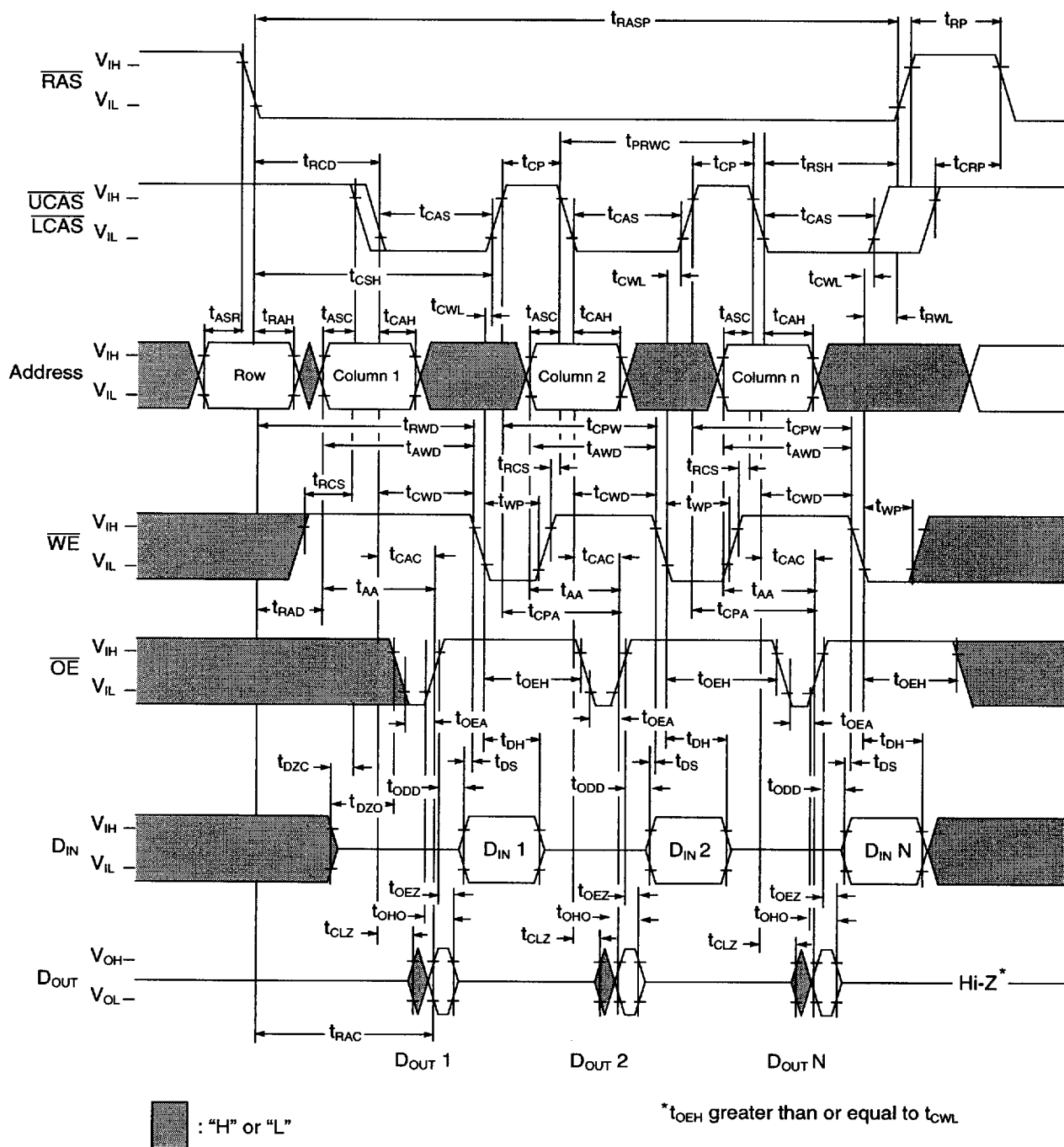
 t_{OEH} greater than or equal to t_{CWL}

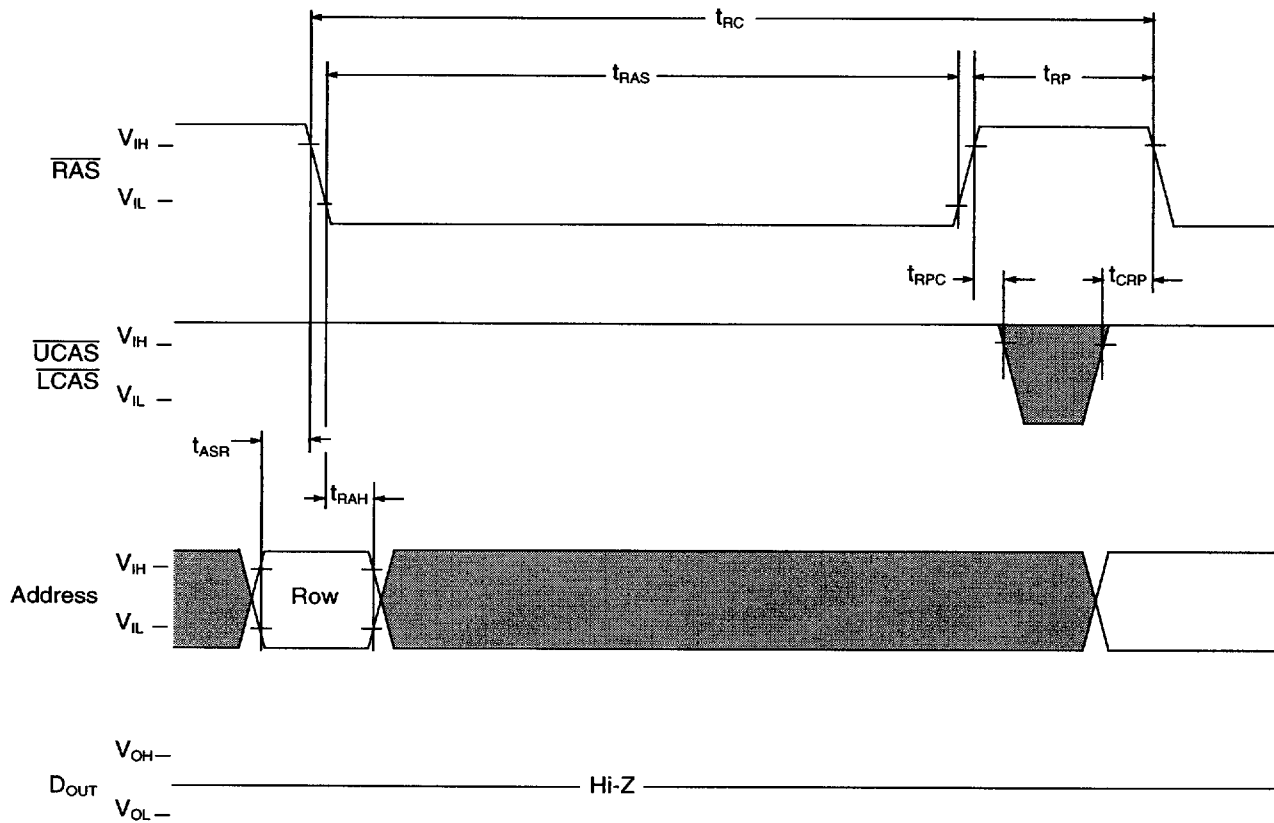
[illegible]

Fast Page Mode Write Cycle



Fast Page Mode Read-Modify-Write Cycle

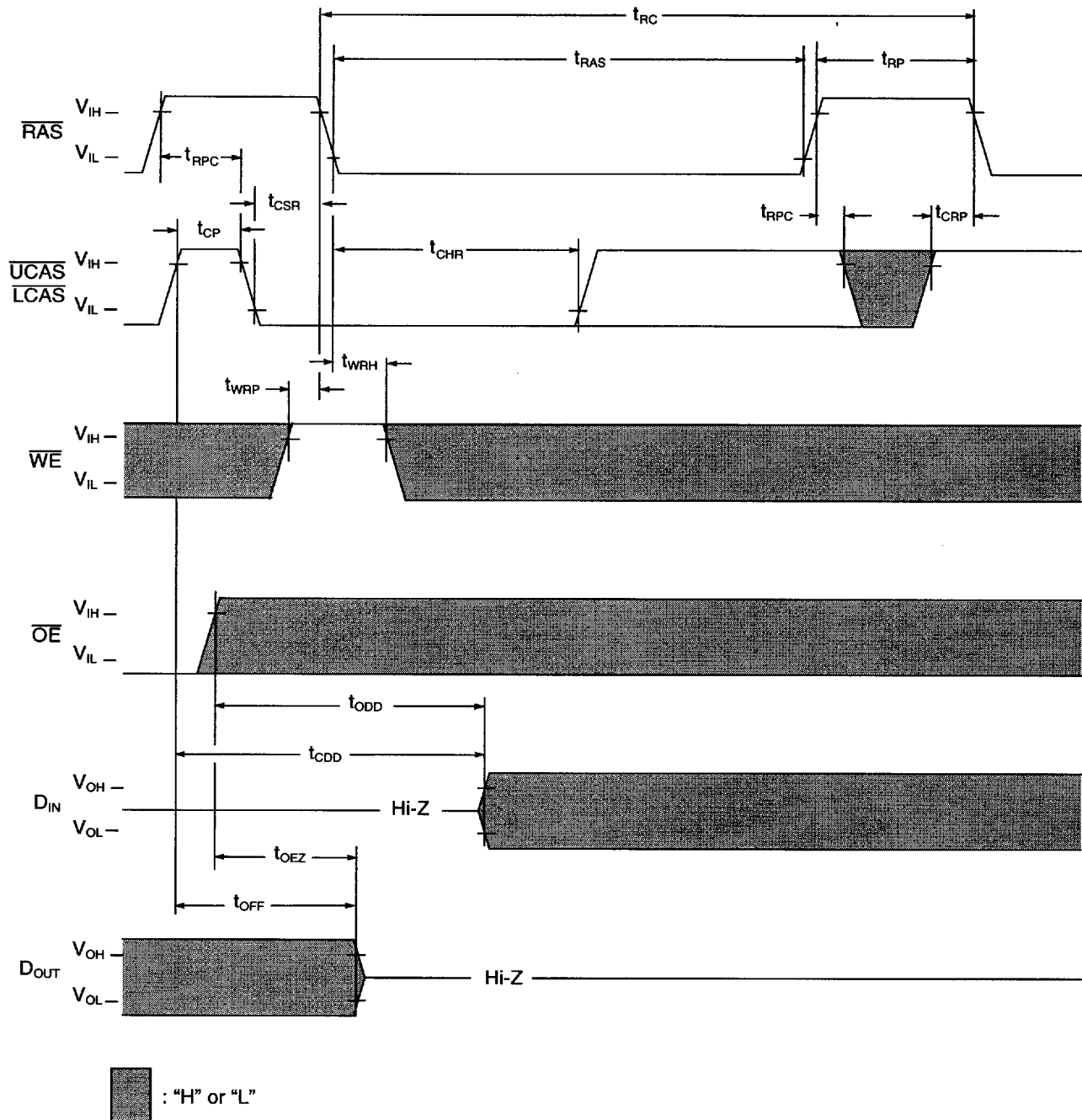


RAS Only Refresh Cycle

■ : "H" or "L"

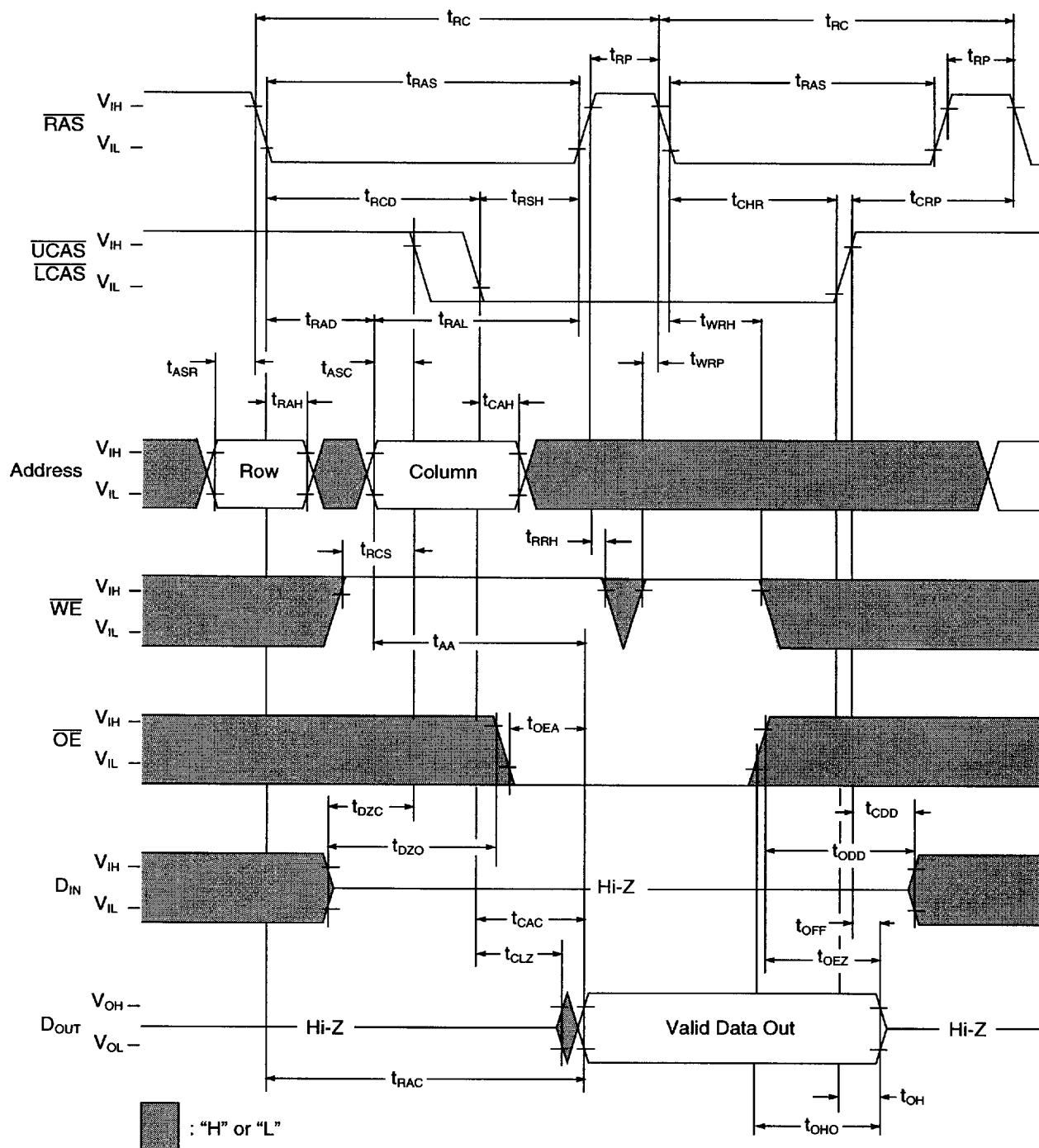
NOTE : $\overline{WE}$, $\overline{OE}$ and D_{IN} are "H" or "L"

CAS Before RAS Refresh Cycle

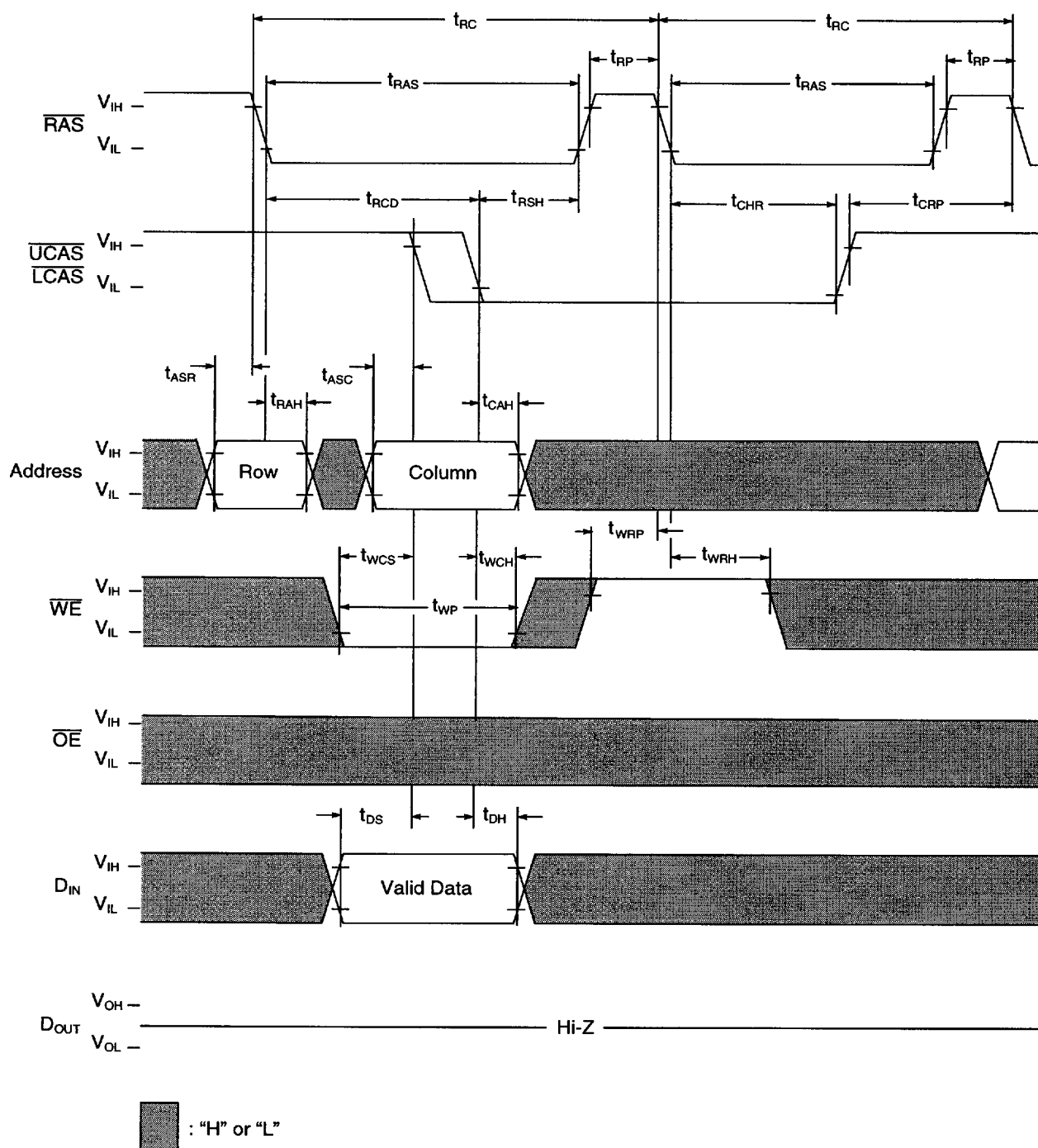


NOTE: Address is "H" or "L"

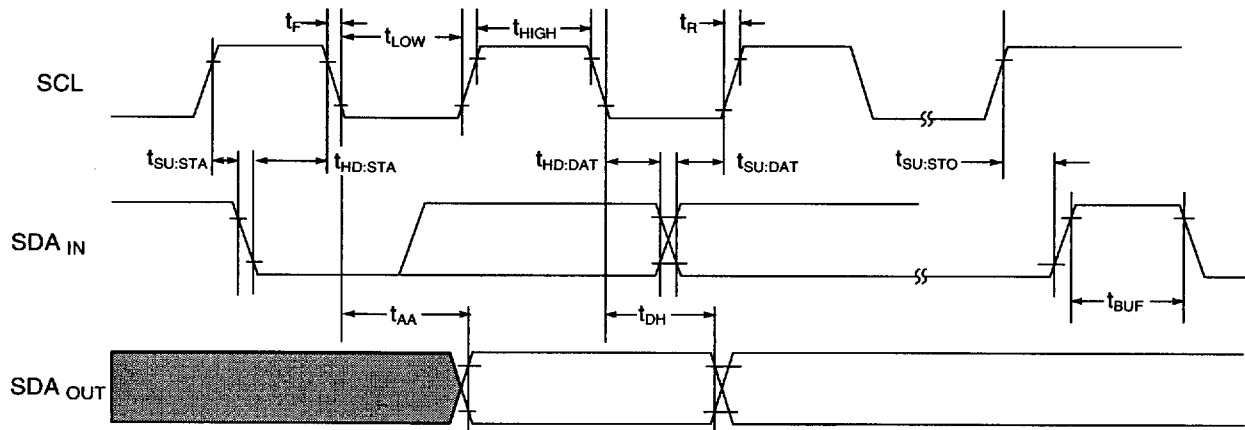
Hidden Refresh Cycle (Read)



Hidden Refresh Cycle (Write)



Presence Detect (EEPROM) Bus Timing



Presence Detect Operation

Clock and Data Conventions: Data states on the SDA line can change only during SCL low. SDA state changes during SCL HIGH are reserved for indicating start and stop conditions (Figure 1 & Figure 2).

Start Condition: All commands are preceded by the start condition, which is a HIGH to LOW transition of SDA when SCL is high. The serial PD device continuously monitors the SDA and SCL lines for the start condition and will not respond to any command until this condition has been met.

Stop Condition: All communications are terminated by a stop condition, which is a LOW to HIGH transition of SDA when SCL is HIGH. The stop condition is also used to place the serial PD device into standby power mode.

Acknowledge: Acknowledge is a software convention used to indicate successful data transfers. The transmitting device, either master or slave, will release the bus after transmitting eight bits. During the ninth clock cycle the receiver will pull the SDA line LOW to acknowledge that it received the eight bits of data (Figure 3).

The PD device will always respond with an acknowledge after recognition of a start condition and its slave address. If both the device and a write operation have been selected, The PD device, will respond with an acknowledge after the receipt of each subsequent eight bit word. In the read mode the PD device will transmit eight bits of data, release the SDA line and monitor the line for an acknowledge. If an acknowledge is detected and no

stop condition is generated by the master, the slave will continue to transmit data. If an acknowledge is not detected, the slave will terminate further data transmissions and await the stop condition to return to standby power mode.

Figure 1. Data Window

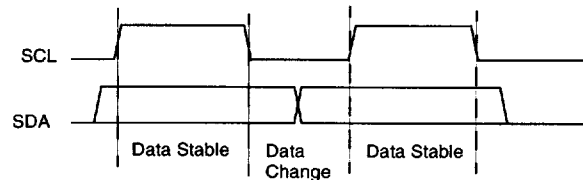


Figure 2. Definition of Start & Stop

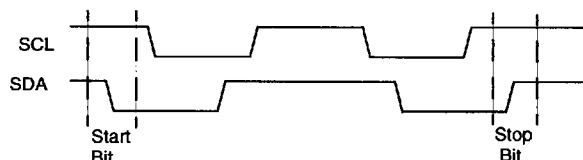
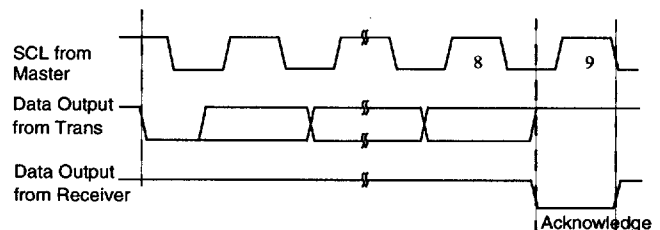
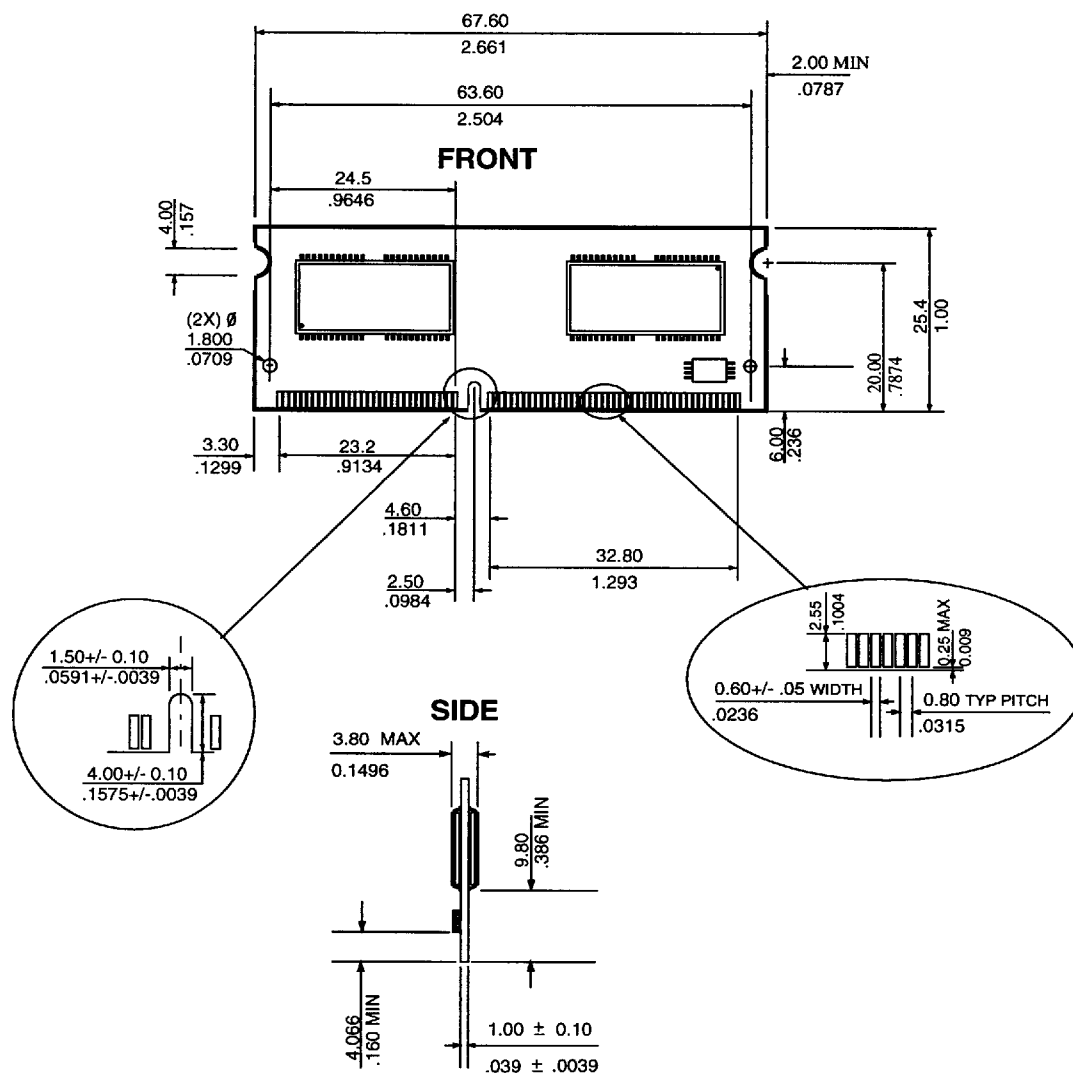


Figure 3. Acknowledge Response From Receiver



Layout Drawing



Revision Log

Rev	Contents of Modification
1/96	Initial Release.